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Should you have any question or inquiry on this matter, please contact our sales staff.

# 大容量積層セラミックコンデンサ HIGH VALUE MULTILAYER CERAMIC **CAPACITORS**

	Code	Temp.characteristics	Operating temp. range
OPERATING TEMP.	ВЈ	В	-25~+85°C
		X5R*	-55~+85°C
	B7	X7R	-55~+125°C
	F	F	-25~+85°C
		Y5V	-30~+85°C

<sup>\*</sup>個別仕様の取交しにより、X7R 仕様に対応している場合があります。

<sup>\*</sup>We may provide X7R for some items according to the individual specification.



#### 特長 FEATURES

- ・電極にNi金属を使用し、端子電極部にメッキをしてあることにより、 はんだ付け性および耐熱性にすぐれ、マイグレーションもほとんど発生 せず、高い信頼性を示します
- ・等価直列抵抗 (ESR) が小さく、 ノイズ吸収性にすぐれています。
- ・特にタンタルおよびアルミ電解コンデンサに比較した場合: 高い許容リップル電流値 高い定格電圧でありながら小型形状 絶縁抵抗、破壊電圧が高く信頼性にすぐれている 等の特徴があります
- The use of Nickel(Ni) as material for both the internal and external electrodes improves the solderability and heat resistance characteristics. This almost completely eliminates migration and raises the level of reliability significantly.
- Low equivalent series resistance(ESR) provides excellent noise absorption characteristics.
- Compared to tantalum or aluminum electrolytic capacitors these ceramic capacitors offer a number of excellent features, including:

Higher permissible ripple current values Smaller case sizes relative to rated voltage Improved reliability due to higher insulation resistance and breakdown voltage.

# 用途 APPLICATIONS

- ・デジタル回路全般
- ・電源バイパスコンデンサ 液晶モジュール用 液晶駆動電圧ライン用 電源電圧の高いLSI、IC、OPアンプ用
- ・平滑コンデンサ DC-DCコンバータ(入力、出力側用) スイッチング電源(2次側用)

- General digital circuit
- · Power supply bypass capacitors Liquid crystal modules Liquid crystal drive voltage lines LS I, I C, converters(both for input and output)
- Smoothing capacitors DC-DC converters (both for input and output) Switching power supplies (secondary side)

#### 形名表記法 **ORDERING CODE**

<b>O</b>		
定格電	Œ〔VDC〕	
Α	4	
J	6.3	
L	10	
E	16	
Т	25	
G	35	
U	50	

積層コンデンサ

シリーズ名

端子電極 メッキ品

形状寸法[EI	A)L×W(mm)
107 (0603)	1.6×0.8
212 (0805)	2.0×1.25
316 (1206)	3.2×1.6
325 (1210)	3.2×2.5

6 温度特性 BJ X5R X7R B7 ΔF Y5V ^= **7** ~ - **7** 

6	
公称静	電容量〔pF〕
例	
473	47,000
105	1,000,000

容量許容差 K ±10% М ±20% Z

8	
製品厚	[み (mm)
K	0.45
Α	0.8
D	0.85
F	1.15
G	1.25
Н	1.5
L	1.6
N	1.9
Y	2.0max
M	2.5

個別仕様 標準 10 包装 φ178mm テーピング (4mmピッチ) 全形状 φ178mm テーピング (4mmピッチ,1000個/リール) 325形状 厚み:M

9



# $B_{1}J_{1}$ 6

Rated voltage (VDC) 6.3 10 Ε 16 25

> 35 50

End termination

4	
Dimensions (c	ase size) (mm)
107 (0603)	1.6×0.8
212 (0805)	2.0×1.25
316 (1206)	3.2×1.6
325 (1210)	32×25

5 Temperature characteristics code BJ X5R B7 X7R △F

Y5V

$\triangle$ :	=Blan	k spa	ace

6	
Nomin	al capacitance (pF)
example	
473	47,000
105	1,000,000

ince tolerance
±10%
±20%
+80 -20 %

Thickness (mm)		
K	0.45	
Α	0.8	
D	0.85	
F	1.15	
G	1.25	
Н	1.5	
L	1.6	
N	1.9	
Υ	2.0max	
M	2.5	

9	
Specia	al code
_	Standard products
10	

Pack	aging
	φ178mm Taping
Т	(4mm pitch)
	All types
	φ178mm Taping
Р	(4mm pitch,1000pcs/reel
	1210Type Thickness: M

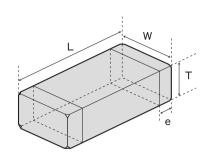
1	
Interna	al code
$\triangle$	Standard products
△=Blan	k space



G

Series name Multilaver ceramic capacitors

# 外形寸法 EXTERNAL DIMENSIONS



注: \*1. ±0.15mm公差あり \*2. ±0.3mm公差あり \*3. ±0.2mm公差あり \*4. +0.15f -0.1mm公差あり Note: \*1. Inclulding dimension tolerance±0.15mm (±0.006 inch).

Note: \*2. Including dimension tolerance  $\pm$ 0.3mm ( $\pm$ 0.012 inch). Note: \*3. Including dimension tolerance  $\pm$ 0.2mm ( $\pm$ 0.008 inch). Note: \*4. Including dimension tolerance  $\pm$ 0.15/ $\pm$ 0.1mm ( $\pm$ 0.006/ $\pm$ 0.004 inch).

Type (EIA)	L	W	Т		е
□MK107	1.6±0.10 <sup>*3,*4</sup>	0.8±0.10 <sup>*3,*4</sup>	0.45±0.05 (0.018±0.002)	K	0.35±0.25
(0603)	(0.063±0.004)	(0.031±0.004)	0.8±0.10 *3,*4 (0.031±0.004)	Α	(0.014±0.010)
			0.45±0.05 (0.018±0.002)	K	
□MK212 (0805)	2.0±0.10 <sup>*1,*3</sup> (0.079±0.004)	1.25±0.10 <sup>*1,*3</sup> (0.049±0.004)	0.85±0.10 (0.033±0.004)	D	0.5±0.25 (0.020±0.010)
			1.25±0.10 *1,*3 (0.049±0.004)	G	
			0.85±0.10 (0.033±0.004)	D	
□MK316	3.2±0.15*3	1.6±0.15*3	1.15±0.10 (0.045±0.004)	F	0.5 <sup>+0.35</sup> -0.25
(1206)	(0.126±0.006)	(0.063±0.006)	1.25±0.10 (0.049±0.004)	G	$(0.020^{+0.014}_{-0.010})$
			1.6±0.20 (0.063±0.008)	L	
			0.85±0.10 (0.033±0.004)	D	
			1.15±0.10 (0.045±0.004)	F	
□MK325	3.2+0.30	2.5±0.20*2	1.5±0.10 (0.059±0.004)	Н	0.6+0.3
(1210)	(0.126±0.012)	(0.098±0.008)	1.9±0.20 (0.075±0.008)	N	(0.024±0.012)
			1.9 <sup>+0.1</sup> <sub>-0.2</sub> (0.075 <sup>+0.004</sup> <sub>-0.008</sub> )	Υ	
			2.5±0.20 *2 (0.098±0.008)	М	
					Unit:mm (inch)

Unit:mm(inch)

# 概略バリエーション AVAILABLE CAPACITANCE RANGE

	т	.1						40	7															_	40									_								04	^								1						_	٥٢					
	Тур			_	_			10	_		_					⊢	_		_	_		_			12	_	_		_	_	_			+	_		_	_				31	b T	_		_	_	_			<del> </del>		_					25				1 -	
	TC		3/X			B/:				X5		-	F/Y	_	_			'X7	H,	4	_		X5		_	ᆫ		K5F		_		/Y!		┸		/X7		4		B/X			┺		K5F		4		'Y5			/X7				X5F		Щ		5R			Y5V
Cap	VD	C 1	6 10	6.3	35	25	16 1	0 6.3	10	6.3	4	50	25	16	10	50	35	25	16	10 5	0 3	5 2	5 16	10	6.3	50	25	16	10	6.3	50	16 1	10 6.	3 5	) 25	16	10	6.3	50 2	25 1	6 1	0 6.3	50	25	10	6.3	4 3	35 2	5 16	10	25	16	10	35	25	16 1	0 6.3	50	35 1	16 1	0 6.3	16	10 6.3
[μF]	3[digi	ts]			П		Т		Г		П								П	Т			Т											Т				П				Т	Г				Т										Т			Т		П	
0.1	104	4	Т	П	Г	П	Т	Т	Т	П	П	Α				G			П	T	G	Т	Т	П		Г			П	П	П	Т		Т	Т		П	П	П	Т	Т	Т	Г			П	Т		Т	П	П		П		П		Т	П	П	T		П	
0.15	154	4	Т	Т	Г		Т	Т	Т	Т	Т				П	П			$\neg$	T	Т		Т	Т		Г					$\neg$	Т	Т	Т	Т		П	П	$\neg$	Т	Т	Т	Т			П	Т			Т	П				П	Т		П	П	Т		П	
0.22	224	4 A	A	A	Г	Α.	A A	4	T	T	T			Α		G			T	1	G	T	Т	Т		Г			П		T	$\neg$		L			П	T	L		Т	T	Т			П	T			T	П		П	П	T			П	П	T		П	$\top$
0.33	334	4	T	Т	П	П	T	T	Т	T	Т					П			$\neg$	T	T	T	Т	Т		Г			П		$\neg$	$\neg$		┰	Т		П	╛	T		Т	Т	Т			П	T			Т	П		П		T			П	П	T		П	
0.47	474	4	Α	A	Г	Α.	A A	4	Т	Т	Т		Α	Α		G			$\neg$	7	G (	G	Т	Т	П	Г				$\neg$	G	T	Т	L			П	T	L	Т	Т	Т	Т			П	T	Т	T	Т	П		П		$\neg$	Т		П	П	Т		П	
0.68	684	4	Т	Т	Г		T	Т	Т		Т					П			$\neg$	T		Т	Т	Т		Г					$\neg$	T	Т	┰	Т		П	T	T		Т	Т	Т			П	T			Т	П		П		$\neg$	Т		П	П	Т		П	
1	108	5 A	A	A	Α	Α.	A A	4	Т		Т	Г	Α	Α	П	П	G	G	G	G		G G	G	G		G				丁	G	T		L	L		П	T	L			Т	Т				T			Т	П							П		Т		П	
2.2	225	5		Т	Г		A A	AA	Т		Т		Α	Α		П			G	G		G	G	G		Г						G		Т	L	L	L	T	$\neg$	LL	-	T	П				Т			Т	П			N				П				П	
3.3	335	5		Т	П		Т	Т	Т		Т	Г				П			$\neg$	П			Т	Т		Г			П	$\neg$		Т		Т	Т		П	T	T			T	П		П		Т			Т	Ν		П		N			П				П	
4.7	475	5			İ		T		Α	A						П			-	G			G	G	G	Г	G		П	$\neg$	T	-	G	Ť	T		L	T	T	LL	-	T	L				T			T	N	N	П		N	N		М	N	T		П	
6.8	68	5		T	Ĺ	T	T		T	T	T					П			T	7	T		T	T		Г			П	$\neg$	T	$\neg$	T	T	T		П	T	T		T	T	T			П	T			T	Ħ		П	П	ヿ	T		Ħ	Ħ	T		П	
10	106	6		T	İ	П	T		Τ	Α	A	Ī				П			T	T	T		Τ	Т		Г		G	G	G	T	-	G	a l	L	L	L	L	T	L	L	L	T	L		П	T	LL	L		N		Ν	N	M.N	N N	1	М		T		П	$\top$
22	226	6		Т	T	П	$\top$		T		Α					П			T	T	T	T	Т	Т		Г			G	G	T	$\neg$		┪	T		П	T	┪	L	L	L	Т			П	T		T	L	П		П	П		VI M	ΥY	П	П	T		N	N
47	476	6	T	Т	П	П	T	T	Т	T	Т					П			$\neg$	T	T	T	Т	Т		Г			П	G	T	$\neg$		┰	Т		П	コ	T		Т	Т	Т		L	L	T		T	Т	П		П	П	T			П		ΜN	Л M.N		N
100	107	7	T	T			$\top$		T	T	Т					П			$\exists$	7	T		T	Т	Т	Г					$\exists$	$\top$	$\top$	T	$\top$			$\neg$	$\neg$	$\top$	T	$\top$	Т			L	L	$\top$					П		$\neg$	$\top$	T			Ν	Л М.Y		

注:グラフの記号は製品の厚み記号です。 Note: Letters in the table indicate thickness.

#### ■低背積層セラミックコンデンサ Low profile Multilayer Ceramic Capacitors

	Туре	Г		-	107	7							2	212	2											3	16										(	325	5		Т	
	TC	B/)	(5R		)	K5F	3		B/)	(7R	В	/X5	R	)	(5F	3	F,	/Y5	٧	B/>	(7R	E	3/>	(5F	3		Χŧ	5R			F/Y	/5V	/	B/)	(7R	-	3/>	(5F	?	F	/Y5	V
			6.3	25	16	10	6.3	4	16	10	25	16	10	10	6.3	4	50	10	6.3	25	16	25	16	10	6.3	25	16	10	6.3	50	35	10	6.3	50	25	50	25	16	10	50	35	10
[μF]	3[digits]										Г						Г					Г			Г	Г				Г	Г			Г		Г			Г	Г		П
0.1	104																Г																			Г				Г		П
0.22	224																D			F																						
0.33	334																																									
0.47	474		Κ						D		D																															
0.68	684																																									
1	105	Κ	Κ	Κ	Κ				D	D	D	D	D								F	D	F											Н		Н						
2.2	225					Κ	Κ	K				D	D					D				D	D							G					Н		Η					
3.3	335																																						D			
4.7	475	Г			Г		Κ	Κ	Г		Г	D	D	Κ	D٠K		Г		D			Г		D	Г	D	D			Г	G	D		Г		Г			D	Н		П
6.8	685				Г				Г		Г						Г					Г			Г	Г				Г	Г			Г		Г			Г	Г		П
10	106													D	D٠K		Г							D	D		D∙F					F	D			Г	D	D	D	Г	Н	F
22	226														D	D												D	D									D				
47	476																												D													$\Box$

注:グラフの記号は製品の厚み記号です。 Note: Letters in the table indicate thickness.

温度特性コード		Tem	温度特性 perature characteri	stics		静電容量許容差〔%〕	tanδ(%)
Temp.char.Code	+1/2	規格 e standard	温度範囲(℃) Temperature range	基準温度(℃) Ref. Temp.	静電容量変化率〔%〕 Capacitance change	Capacitance tolerance	Dissipation factor
- D.I	JIS	В	-25~+85	20	±10	1.40(14)	
BJ	EIA	X5R	<b>−55∼+85</b>	25	±15	±10(K) ±20(M)	2.5 max.*
B7	EIA	X7R	−55~+125	25	±15	<u> </u>	
	JIS	F	-25~+85	20	+30/-80	+80 -20 <sup>(Z)</sup>	7.0 max.*
Г	EIA	Y5V	-30~+85	25	+22/-82	$-20^{(Z)}$	7.0 max.

<sup>\*:</sup>代表的な値を記載しています。詳細はアイテム一覧表を参照ください。\*:The figure indicates typical value. Please refer to PART NUMBERS table.

セレクションガイド Selection Guide

アイテム一覧 Part Numbers P.46

特性図 **Electrical Characteristics** 

P.54

梱包 Packaging P.98 信頼性 Reliability Data P.102 使用上の注意 Precautions P.108

▼ P.12

etc ⚠当社カタログをご使用の際には「当社製品に関するお断り」を必ずお読みください。

TAIYO YUDEN 2009

#### ■ 107TYPE —

【温度特性 Temp.char. BJ:B/X5R】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
35V	GMK107 BJ105□A*1	RoHS	1	B/X5R	5	5		0.8±0.1
	TMK107 BJ105□K*1	RoHS	1	X5R	10	R		0.45±0.05
25V	TMK107 BJ224□A	RoHS	0.22	B/X5R	3.5	R/W		0.8±0.1
23 V	TMK107 BJ474□A*1	RoHS	0.47	B/X5R	3.5	R		0.8±0.1
	TMK107 BJ105□A* <sup>1</sup>	RoHS	1	B/X5R	5	n		0.8±0.1
	EMK107 BJ105□K* <sup>1</sup>	RoHS	1	X5R	10	R		0.45±0.05
	EMK107 BJ224□A	RoHS	0.22	B/X5R*2	3.5	R/W		0.8±0.1
16V	EMK107 BJ474□A	RoHS	0.47	B/X5R	3.5			0.8±0.1
	EMK107 BJ105□A*1	RoHS	1	B/X5R	5			0.8±0.1
	EMK107 BJ225□A* <sup>1</sup>	RoHS	2.2	B/X5R	10	R	±10%	0.8±0.1
	LMK107 BJ105□K*1	RoHS	1	B/X5R	10		±20%	0.45±0.05
	LMK107 BJ225□K*1	RoHS	2.2	X5R	10			0.45±0.05
	LMK107 BJ224□A	RoHS	0.22	B/X5R*2	3.5	R/W		0.8±0.1
10V	LMK107 BJ474□A	RoHS	0.47	B/X5R*2	3.5			0.8±0.1
	LMK107 BJ105□A*1	RoHS	1	B/X5R*2	5			0.8±0.1
	LMK107 BJ225 ☐ A*1	RoHS	2.2	B/X5R	10			0.8±0.1
	LMK107 BJ475□A*1	RoHS	4.7	X5R	10			0.8±0.1
	JMK107 BJ474□K	RoHS	0.47	B/X5R	5			0.45±0.05
	JMK107 BJ105□K*1	RoHS	1	B/X5R	10			0.45±0.05
	JMK107 BJ225□K*1	RoHS	2.2	X5R	10			0.45±0.05
6.3V	JMK107 BJ475MK* <sup>1,*3</sup>	RoHS	4.7	X5R	10	R	±20%	0.45±0.05
	JMK107 BJ225□A*1	RoHS	2.2	B/X5R	10	l n	±10%	0.8±0.1
	JMK107 BJ475□A*1	RoHS	4.7	X5R	10		±20%	0.8±0.1
	JMK107 BJ106MA*1,*3	RoHS	10	X5R	10		±20%	0.8+0.15/-0.1
	AMK107 BJ225□K* <sup>1</sup>	RoHS	2.2	X5R	10		±10% ±20%	0.45±0.05
4V	AMK107 BJ475MK*1	RoHS	4.7	X5R	10			0.45±0.05
	AMK107 BJ106MA*1	RoHS	10	X5R	10		±20%	0.8±0.1
	AMK107 BJ226MA*1,*3	RoHS	22	X5R	10			0.8±0.2

形名の□には静電容量許容差記号が入ります。

- \*1 高温負荷試験の試験電圧は定格電圧の 1.5 倍
- \*2 個別仕様の取交しにより、X7R仕様に対応している場合があります。
- \*3 ご使用の回路や機器により、個別仕様の取り交わしが必要になります。 必ず正規販売チャンネルにお問い合わせください。
- $\hfill \square$  Please specify the capacitance tolerance code.
- \*1 Test Voltage of Loading at high temperature test is 1.5 time of the rated voltage
- \*2 We may provide X7R for some items according to the individual specification.
- \*3 The exchange of individual specification is necessary depending on the application and circuit condition. Please contact Taiyo Yuden sales channel.

#### 【温度特性 Temp.char. B7:X7R】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
16V	EMK107 B7224□A*1	RoHS	0.22	X7R	3.5	R/W		0.8±0.1
167	EMK107 B7 105 ☐ A*1	RoHS	1	X7R	5	R		0.8±0.1
	LMK107 B7224□A	RoHS	0.22	X7R	3.5	R/W		0.8±0.1
10V	LMK107 B7 474□A	RoHS	0.47	X7R	3.5	Б	±10%	0.8±0.1
	LMK107 B7 105 ☐ A*1	RoHS	1	X7R	5	R	±20%	0.8±0.1
	JMK107 B7224□A	RoHS	0.22	X7R	3.5	R/W		0.8±0.1
6.3V	JMK107 B7474□A	RoHS	0.47	X7R	3.5	Б		0.8±0.1
	JMK107 B7 105□A*1	RoHS	1	X7R	5	R		0.8±0.1

形名の□には静電容量許容差記号が入ります。

<sup>\*1</sup> 高温負荷試験の試験電圧は定格電圧の 1.5 倍

 $<sup>\</sup>hfill \square$  Please specify the capacitance tolerance code.

<sup>\*1</sup> Test Voltage of Loading at high temperature test is 1.5 time of the rated voltage.

【温度特性 Temp.char. F:F/Y5V】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor [%] Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
50V	UMK107 F104ZA	RoHS	0.1	F/Y5V	7			0.8±0.1
25V	TMK107 F474ZA	RoHS	0.47	F/Y5V	7	R/W		0.8±0.1
	EMK107 F224ZA	RoHS	0.22	F/Y5V	7	□/ VV		0.8±0.1
16V	EMK107 F474ZA	RoHS	0.47	F/Y5V	7		+80%	0.8±0.1
100	EMK107 F105ZA	RoHS	1	F/Y5V	16		-20%	0.8±0.1
	EMK107 F225ZA	RoHS	2.2	F/Y5V	16	В		0.8±0.1
101/	LMK107 F105ZA	RoHS	1	F/Y5V	16	R		0.8±0.1
10V	LMK107 F225ZA	RoHS	2.2	F/Y5V	16			0.8±0.1

#### ■ 212TYPE —

【温度特性 Temp.char. BJ:B/X5R】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor [%] Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
	UMK212 BJ104□G	RoHS	0.1	B/X5R*2	3.5			1.25±0.1
	UMK212 BJ224□G*1	RoHS	0.22	B/X5R*2	3.5			1.25±0.1
50V	UMK212 BJ474□G*1	RoHS	0.47	B/X5R	3.5	5 444		1.25±0.1
	UMK212 BJ105□G*1	RoHS	1	X5R	5	R/W		1.25±0.1
	GMK212 BJ474□G	RoHS	0.47	B/X5R	3.5			1.25±0.1
35V	GMK212 BJ105□G* <sup>1</sup>	RoHS	1	B/X5R*2	3.5	•		1.25±0.1
	TMK212 BJ474□D	RoHS	0.47	B/X5R	3.5			0.85±0.1
	TMK212 BJ105□D	RoHS	1	B/X5R	5			0.85±0.1
25V	TMK212 BJ105□G	RoHS	1	B/X5R	5	R		1.25±0.1
	TMK212 BJ225□G*1	RoHS	2.2	B/X5R	5			1.25±0.1
	TMK212 BJ475□G*1	RoHS	4.7	X5R	10			1.25±0.15
	EMK212 BJ105□D	RoHS	1	B/X5R	5			0.85±0.1
	EMK212 BJ225□D	RoHS	2.2	B/X5R	5	R		0.85±0.1
	EMK212 BJ475 □ D*1,*3	RoHS	4.7	B/X5R	10		±10%	0.85±0.1
16V	EMK212 BJ105□G	RoHS	1	B/X5R*2	3.5	R/W	±20%	1.25±0.1
	EMK212 BJ225□G	RoHS	2.2	B/X5R*2	5			1.25±0.1
	EMK212 BJ475□G*1	RoHS	4.7	B/X5R	5			1.25±0.15
	EMK212 BJ106 ☐ G*1,*3	RoHS	10	X5R	10			1.25±0.15
	LMK212 BJ475□K*1	RoHS	4.7	X5R	10	<u> </u>		0.45±0.05
	LMK212 BJ105□D	RoHS	1	B/X5R*2	3.5	R		0.85±0.1
	LMK212 BJ225□D	RoHS	2.2	B/X5R	5			0.85±0.1
	LMK212 BJ475□D	RoHS	4.7	B/X5R	10	•		0.85±0.1
40) /	LMK212 BJ106□D*1	RoHS	10	X5R	10			0.85±0.1
10V	LMK212 BJ105□G	RoHS	1	B/X5R*2	3.5	R/W		1.25±0.1
	LMK212 BJ225□G	RoHS	2.2	B/X5R*2	5			1.25±0.1
	LMK212 BJ475□G	RoHS	4.7	B/X5R	5			1.25±0.15
	LMK212 BJ106□G	RoHS	10	X5R	10			1.25±0.15
	LMK212 BJ226MG*1,*3	RoHS	22	X5R	10		±20%	1.25±0.2
	JMK212 BJ475□K* <sup>1</sup>	RoHS	4.7	X5R	10		±10% ±20%	0.45±0.05
	JMK212 BJ106MK*1,*3	RoHS	10	X5R	10		±20%	0.45±0.05
	JMK212 BJ475□D	RoHS	4.7	X5R	10	R	±10% ±20%	0.85±0.1
6.3V	JMK212 BJ106□D	RoHS	10	X5R	10		1.000/	0.85±0.1
	JMK212 BJ226MD* <sup>1,*3</sup>	 RoHS	22	X5R	10		±20%	0.85±0.1
	JMK212 BJ475□G	 RoHS	4.7	B/X5R	5		±10%	1.25±0.15
	JMK212 BJ106□G	RoHS	10	X5R	10		±20%	1.25±0.15
	JMK212 BJ226MG*1,*3	RoHS	22	X5R	10			1.25±0.15
	JMK212 BJ476MG*1,*3	RoHS	47	X5R	10		±20%	1.25±0.2
4V	AMK212 BJ226MD*1	RoHS	22	X5R	10			0.85±0.1

形名の□には静電容量許容差記号が入ります。

<sup>\*1</sup> 高温負荷試験の試験電圧は定格電圧の 1.5 倍

<sup>\*2</sup> 個別仕様の取交しにより、X7R仕様に対応している場合があります。

<sup>\*3</sup> ご使用の回路や機器により、個別仕様の取り交わしが必要になります。 必ず正規販売チャンネルにお問い合わせください。

 $<sup>\</sup>square$  Please specify the capacitance tolerance code.

<sup>\*1</sup> Test Voltage of Loading at high temperature test is 1.5 time of the rated voltage.

<sup>\*2</sup> We may provide X7R for some items according to the individual specification.

<sup>\*3</sup> The exchange of individual specification is necessary depending on the application and circuit condition. Please contact Taiyo Yuden sales channel.

### 【温度特性 Temp.char. B7:X7R】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
	UMK212 B7 104□G	RoHS	0.1	X7R	3.5			1.25±0.1
50V	UMK212 B7224□G*1	RoHS	0.22	X7R	3.5	D ///		1.25±0.1
	UMK212 B7 474□G*1	RoHS	0.47	X7R	3.5	R/W		1.25±0.1
35V	GMK212 B7 105 ☐ G*1	RoHS	1	X7R	3.5			1.25±0.1
25V	TMK212 B7 105 ☐ G*1	RoHS	1	X7R	5	R		1.25±0.1
	EMK212 B7 474□D	RoHS	0.47	X7R	3.5	R/W	±10%	0.85±0.1
401/	EMK212 B7 105□D	RoHS	1	X7R	5	R	±20%	0.85±0.1
16V	EMK212 B7 105□G	RoHS	1	X7R	3.5	R/W		1.25±0.1
	EMK212 B7 225 ☐ G*1	RoHS	2.2	X7R	10	R		1.25±0.1
	LMK212 B7 105□D	RoHS	1	X7R	3.5	n		0.85±0.1
101/	LMK212 B7 105□G	RoHS	1	X7R	3.5	R/W		1.25±0.1
10V	LMK212 B7225□G	RoHS	2.2	X7R	5	R		1.25±0.1
	LMK212 B7 475□G*1	RoHS	4.7	X7R	10	R/W		1.25±0.15

形名の□には静電容量許容差記号が入ります。

### 【温度特性 Temp.char. F:F/Y5V】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
	UMK212 F224ZD	RoHS	0.22	F/Y5V	7			0.85±0.1
50V	UMK212 F474ZG	RoHS	0.47	F/Y5V	7	R/W		1.25±0.1
	UMK212 F105ZG	RoHS	1	F/Y5V	7	rn/ vv		1.25±0.1
16V	EMK212 F225ZG	RoHS	2.2	F/Y5V	7		1.000/	1.25±0.1
	LMK212 F225ZD	RoHS	2.2	F/Y5V	9		+80% -20%	0.85±0.1
10V	LMK212 F475ZG	RoHS	4.7	F/Y5V	9		-20%	1.25±0.1
	LMK212 F106ZG	RoHS	10	F/Y5V	16	R		1.25±0.1
6.3V	JMK212 F475ZD	RoHS	4.7	F/Y5V	16			0.85±0.1
0.3V	JMK212 F106ZG	RoHS	10	F/Y5V	16			1.25±0.1

<sup>\*1</sup> 高温負荷試験の試験電圧は定格電圧の 1.5 倍

 $<sup>\</sup>square$  Please specify the capacitance tolerance code.

<sup>\*1</sup> Test Voltage of Loading at high temperature test is 1.5 time of the rated voltage.

#### ■ 316TYPE -

【温度特性 Temp.char. BJ:B/X5R】

加坡大利工	cirip.citai. bo.b/xort							
定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
	UMK316 BJ224□L	RoHS	0.22	B/X5R*2	2.5	D/W		1.6±0.2
50)/	UMK316 BJ474□L	RoHS	0.47	B/X5R*2	3.5	R/W		1.6±0.2
50V	UMK316 BJ105□L	RoHS	1	B/X5R*2	3.5			1.6±0.2
	UMK316 BJ475□L*1	RoHS	4.7	X5R	10			1.6±0.2
	TMK316 BJ105□D	RoHS	1	B/X5R	3.5	•		0.85±0.1
	TMK316 BJ225□D*1	RoHS	2.2	B/X5R	3.5			0.85±0.1
	TMK316 BJ475□D* <sup>1</sup>	RoHS	4.7	X5R	5			0.85±0.1
25V	TMK316 BJ225□L	RoHS	2.2	B/X5R*2	3.5	R		1.6±0.2
	TMK316 BJ475□L* <sup>1</sup>	RoHS	4.7	B/X5R	5		±10%	1.6±0.2
	TMK316 BJ106□L*1	RoHS	10	X5R	5		±20%	1.6±0.2
	EMK316 BJ225 ☐ D	RoHS	2.2	B/X5R	3.5			0.85±0.1
	EMK316 BJ475□D	RoHS	4.7	X5R	5			0.85±0.1
	EMK316 BJ106□D*1	RoHS	10	X5R	10			0.85±0.1
	EMK316 BJ105□F	RoHS	1	B/X5R*2	3.5	R/W		1.15±0.1
16V	EMK316 BJ106□F* <sup>1</sup>	RoHS	10	X5R	10	R		1.15±0.1
	EMK316 BJ225□L	RoHS	2.2	B/X5R*2	3.5	R/W		1.6±0.2
	EMK316 BJ475□L	RoHS	4.7	B/X5R	5			1.6±0.2
	EMK316 BJ106□L* <sup>1</sup>	RoHS	10	B/X5R	5			1.6±0.2
	EMK316 BJ226ML*1	RoHS	22	B/X5R	10		±20%	1.6±0.2
	LMK316 BJ475□D	RoHS	4.7	B/X5R	5		±10%	0.85±0.1
	LMK316 BJ106□D	RoHS	10	B/X5R	10		±20%	0.85±0.1
	LMK316 BJ226MD*1,*3	RoHS	22	X5R	10		±20%	0.85±0.1
10V	LMK316 BJ106□L	RoHS	10	B/X5R	5		±10% ±20%	1.6±0.2
	LMK316 BJ226ML*1	RoHS	22	B/X5R	10		1.000/	1.6±0.2
	LMK316 BJ476ML*1,*3	RoHS	47	X5R	10	R	±20%	1.6±0.2
	JMK316 BJ106□D	RoHS	10	B/X5R	10		±10% ±20%	0.85±0.1
	JMK316 BJ226MD*1,*3	RoHS	22	X5R	10			0.85±0.1
	JMK316 BJ476MD*1,*3	RoHS	47	X5R	10		±20%	0.85±0.1
6.3V	JMK316 BJ106□L	RoHS	10	B/X5R*2	5		±10%	1.6±0.2
	JMK316 BJ226□L	RoHS	22	B/X5R	10		±20%	1.6±0.2
	JMK316 BJ476ML*3	RoHS	47	X5R	10			1.6±0.2
	JMK316 BJ107ML*1,*3	RoHS	100	X5R	10		±20%	1.6±0.2
4V	AMK316 BJ107ML*1	RoHS	100	X5R	10			1.6±0.2
	1	l			1	l		

形名の□には静電容量許容差記号が入ります。

- \*1 高温負荷試験の試験電圧は定格電圧の 1.5 倍
- \*2 個別仕様の取交しにより、X7R仕様に対応している場合があります。
- \*3 ご使用の回路や機器により、個別仕様の取り交わしが必要になります。 必ず正規販売チャンネルにお問い合わせください。

【温度特性 Temp.char. B7:X7R】

- ☐ Please specify the capacitance tolerance code.
- \*1 Test Voltage of Loading at high temperature test is 1.5 time of the rated voltage.
- \*2 We may provide X7R for some items according to the individual specification.
- \*3 The exchange of individual specification is necessary depending on the application and circuit condition. Please contact Taiyo Yuden sales channel.

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
	UMK316 B7 224□L	RoHS	0.22	X7R	2.5			1.6±0.2
50V	UMK316 B7 474□L	RoHS	0.47	X7R	3.5		— ±10%	1.6±0.2
	UMK316 B7 105□L	RoHS	1	X7R	3.5	R/W		1.6±0.2
	TMK316 B7 224□F	RoHS	0.22	X7R	2.5			1.15±0.1
051/	TMK316 B7 105□L	RoHS	1	X7R	3.5			1.6±0.2
25V	TMK316 B7 225□L	RoHS	2.2	X7R	3.5	Б		1.6±0.2
	TMK316 B7 106□L*1	RoHS	10	X7R	10	R		1.6±0.2
	EMK316 B7 105□F	RoHS	1	X7R	3.5	R/W	±20%	1.15±0.1
16V	EMK316 B7 225□L	RoHS	2.2	X7R	3.5	H/ VV		1.6±0.2
	EMK316 B7 106 ☐ L*1	RoHS	10	X7R	10	R		1.6±0.2
	LMK316 B7 225□L	RoHS	2.2	X7R	3.5	R/W		1.6±0.2
10V	LMK316 B7 475□L	RoHS	4.7	X7R	5			1.6±0.2
	LMK316 B7 106□L*1	RoHS	10	X7R	5	R		1.6±0.2
6.3V	JMK316 B7 106□L	RoHS	10	X7R	5			1.6±0.2

形名の□には静電容量許容差記号が入ります。

<sup>\*1</sup> 高温負荷試験の試験電圧は定格電圧の 1.5 倍

 $<sup>\</sup>hfill \square$  Please specify the capacitance tolerance code.

<sup>\*1</sup> Test Voltage of Loading at high temperature test is 1.5 time of the rated voltage.

【温度特性 Temp.char. F:F/Y5V】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
50V	UMK316 F225ZG	RoHS	2.2	F/Y5V	7	R/W		1.25±0.1
35V	GMK316 F475ZG	RoHS	4.7	F/Y5V	7			1.25±0.1
337	GMK316 F106ZL	RoHS	10	F/Y5V	9			1.6±0.2
25V	TMK316 F106ZL	RoHS	10	F/Y5V	9			1.6±0.2
16V	EMK316 F106ZL	RoHS	10	F/Y5V	9	ь	+80% -20%	1.6±0.2
	LMK316 F475ZD	RoHS	4.7	F/Y5V	9	R	-20%	0.85±0.1
10V	LMK316 F106ZF	RoHS	10	F/Y5V	16			1.15±0.1
	LMK316 F226ZL	RoHS	22	F/Y5V	16			1.6±0.2
6.3V	JMK316 F106ZD	RoHS	10	F/Y5V	16			0.85±0.1

#### ■ 325TYPE -

【温度特性 Temp.char. BJ:B/X5R】

定格電圧 Rated Voltage	形 名 Ordering code		EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
	UMK325 BJ105□H		RoHS	1	B/X5R*2	3.5	R/W	±10% ±20%	1.5±0.1
50V	UMK325 BJ475MM*1		RoHS	4.7	X5R	5			2.5±0.2
	UMK325 BJ106MM* <sup>1</sup>		RoHS	10	X5R	5			2.5±0.2
	GMK325 BJ225MN		RoHS	2.2	B/X5R	3.5			1.9±0.2
35V	GMK325 BJ475MN*1		RoHS	4.7	X5R	10			1.9±0.2
	GMK325 BJ106MN*1		RoHS	10	B/X5R	5			1.9±0.2
	TMK325 BJ106MD*1		RoHS	10	B/X5R	5			0.85±0.1
	TMK325 BJ225MH		RoHS	2.2	B/X5R*2	3.5			1.5±0.1
051/	TMK325 BJ335MN		RoHS	3.3	B/X5R*2	3.5			1.9±0.2
25V	TMK325 BJ475MN		RoHS	4.7	B/X5R*2	3.5			1.9±0.2
	TMK325 BJ106MN		RoHS	10	B/X5R	5			1.9±0.2
	TMK325 BJ106MM* <sup>1</sup>		RoHS	10	B/X5R	3.5			2.5±0.2
	EMK325 BJ106MD*1		RoHS	10	B/X5R	5			0.85±0.1
	EMK325 BJ226MD*1,*3		RoHS	22	B/X5R	10			0.85±0.1
101/	EMK325 BJ475MN		RoHS	4.7	B/X5R*2	3.5			1.9±0.2
16V	EMK325 BJ106MN		RoHS	10	B/X5R	3.5	R	±20%	1.9±0.2
	EMK325 BJ226MM*1		RoHS	22	B/X5R	5	n		2.5±0.2
	EMK325 BJ476MM* <sup>1</sup>		RoHS	47	X5R	10			2.5±0.2
	LMK325 BJ335MD		RoHS	3.3	B/X5R	3.5			0.85±0.1
	LMK325 BJ475MD		RoHS	4.7	B/X5R	5			0.85±0.1
	LMK325 BJ106MD*1		RoHS	10	B/X5R	5			0.85±0.1
40) (	LMK325 BJ226MY*1		RoHS	22	B/X5R	5			1.9+0.1/-0.2
10V	LMK325 BJ106MN		RoHS	10	B/X5R*2	3.5			1.9±0.2
	LMK325 BJ226MM		RoHS	22	B/X5R	5			2.5±0.2
	LMK325 BJ476MM*1		RoHS	47	X5R	10			2.5±0.2
	LMK325 BJ107MM*1,*3	·	RoHS	100	X5R	10			2.5±0.3
	JMK325 BJ226MY		RoHS	22	B/X5R	5			1.9+0.1/-0.2
	JMK325 BJ107MY*1,*3		RoHS	100	X5R	10			1.9+0.1/-0.2
6.3V	JMK325 BJ476MN*1		RoHS	47	X5R	10			1.9±0.2
	JMK325 BJ476MM* <sup>1</sup>		RoHS	47	X5R	10			2.5±0.2
	JMK325 BJ107MM* <sup>1</sup>		RoHS	100	X5R	10			2.5±0.3

形名の□には静電容量許容差記号が入ります。

▲当社カタログをご使用の際には「当社製品に関するお断り」を必ずお読みください。

<sup>\*1</sup> 高温負荷試験の試験電圧は定格電圧の 1.5 倍

<sup>\*2</sup> 個別仕様の取交しにより、X7R仕様に対応している場合があります。

<sup>\*3</sup> ご使用の回路や機器により、個別仕様の取り交わしが必要になります。 必ず正規販売チャンネルにお問い合わせください。

 $<sup>\</sup>hfill \square$  Please specify the capacitance tolerance code.

<sup>\*1</sup> Test Voltage of Loading at high temperature test is 1.5 time of the rated voltage.

<sup>\*2</sup> We may provide X7R for some items according to the individual specification.

<sup>\*3</sup> The exchange of individual specification is necessary depending on the application and circuit condition. Please contact Taiyo Yuden sales channel.

【温度特性 Temp.char. B7:X7R】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
50V	UMK325 B7 105□H	RoHS	1	X7R	3.5	R/W	±10% ±20%	1.5±0.1
	TMK325 B7225MH	RoHS	2.2	X7R	3.5			1.5±0.1
051/	TMK325 B7335MN	RoHS	3.3	X7R	3.5			1.9±0.2
25V	TMK325 B7475MN*1	RoHS	4.7	X7R	3.5	R	±20%	1.9±0.2
	TMK325 B7 106MN*1	RoHS	10	X7R	5	n n	±20%	1.9±0.2
16V	EMK325 B7 475MN	RoHS	4.7	X7R	3.5			1.9±0.2
10V	LMK325 B7 106MN	RoHS	10	X7R	3.5			1.9±0.2

形名の□には静電容量許容差記号が入ります。

### 【温度特性 Temp.char. F:F/Y5V】

定格電圧 Rated Voltage	形 名 Ordering code	EHS (Environmental Hazardous Substances)	公 称 静電容量 Capacitance 〔µF〕	温度特性 Temperature characteristics	tan δ Dissipation factor (%) Max.	実装条件 Soldering method R:リフロー Reflow soldering W: フロー Wave soldering	静電容量 許 容 差 Capacitance tolerance	厚み Thickness 〔mm〕
50V	UMK325 F475ZH	RoHS	4.7	F/Y5V	7			1.5±0.1
35V	GMK325 F106ZH	RoHS	10	F/Y5V	7		+80%	1.5±0.1
16V	EMK325 F226ZN	RoHS	22	F/Y5V	16	R		1.9±0.2
10V	LMK325 F106ZF	RoHS	10	F/Y5V	16	n	-20%	1.15±0.1
100	LMK325 F226ZN	RoHS	22	F/Y5V	16			1.9±0.2
6.3V	JMK325 F476ZN	RoHS	47	F/Y5V	16			1.9±0.2

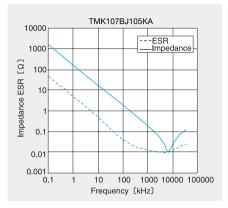
<sup>\*1</sup> 高温負荷試験の試験電圧は定格電圧の 1.5 倍

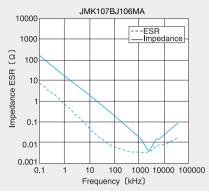
 $<sup>\</sup>square$  Please specify the capacitance tolerance code.

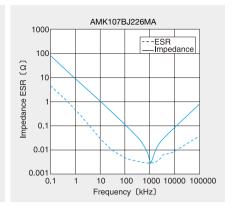
<sup>\*1</sup> Test Voltage of Loading at high temperature test is 1.5 time of the rated voltage.

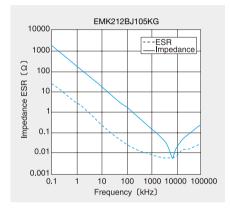
インピーダンス・ESR一周波数特性例 Example of Impedance ESR vs. Frequency characteristics

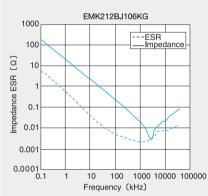
・当社積層セラミックコンデンサ例 (Taiyo Yuden multilayer ceramic capacitor)

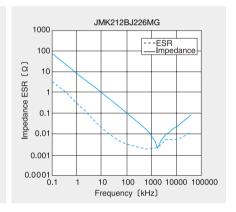


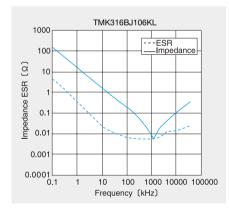


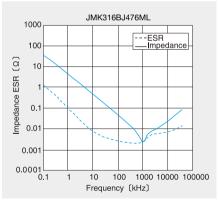


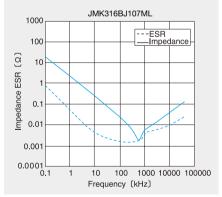


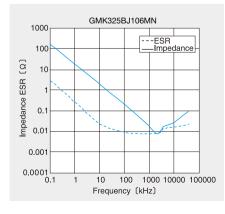


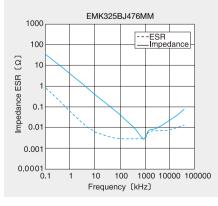


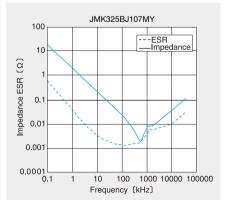


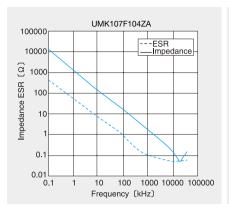


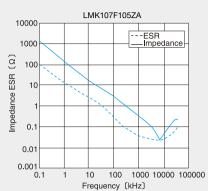


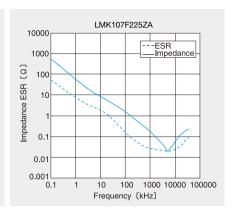


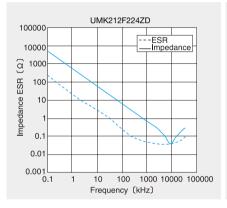


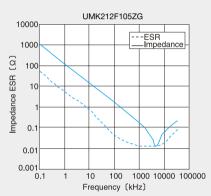


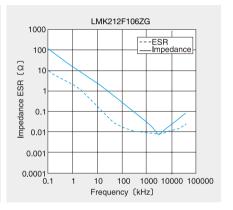


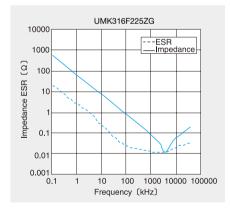


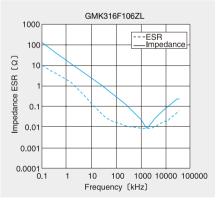


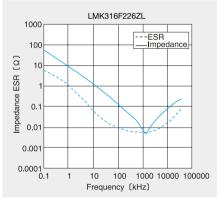


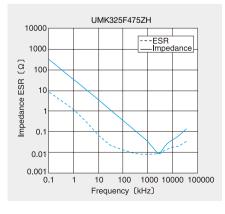


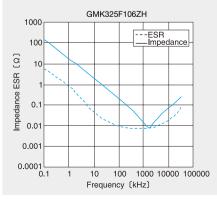


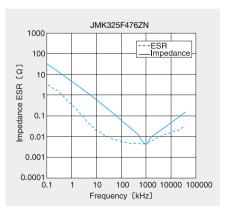












### 梱包 PACKAGING

### ①最小受注単位数 Minimum Quantity

# ■テーピング梱包 Taped packaging

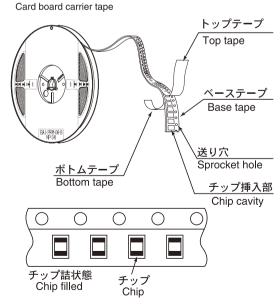
	製品厚み			数量	
形式(EIA) Type	Thickness		Standard [ pc	d quantity s ]	
.,,,,	mm(inch)	code	紙テープ paper	エンボステープ Embossed tape	
☐MK042 (01005)	0.2 (0.008)	С	15000	_	
☐MK063(0201)	0.3 (0.012)	Р	15000	_	
□2K096(0302)	0.3 (0.012)	Р	10000		
□2KU96(U3U2)	0.45 (0.018)	K	10000	_	
□WK105(0204)	0.3 (0.012)	Р	10000	_	
☐MK105(0402)	0.5 (0.020)	V, W	10000		
□VK105 (0402)	0.5 (0.020)	W	10000	_	
	0.45 (0.018)	K	4000	_	
☐MK107(0603) ☐WK107(0306)	0.5 (0.020)	V	_	4000	
	0.8(0.031)	Α	4000	_	
	0.5 (0.020)	V	4000	_	
□2K110(0504)	0.8(0.031)	А	4000	_	
	0.6 (0.024)	В	4000	_	
	0.45 (0.018)	K	4000	_	
☐MK212(0805) ☐WK212(0508)	0.85 (0.033)	D	4000	_	
	1.25 (0.049)	G	_	3000	
☐4K212(0805)	0.85 (0.033)	D	4000	_	
□2K212(0805)	0.85 (0.033)	D	4000	_	
	0.85 (0.033)	D	4000	_	
	1.15 (0.045)	F		3000	
□MK316(1206)	1.25 (0.049)	G	_	3000	
	1.6 (0.063)	L	_	2000	
	0.85 (0.033)	D			
	1.15 (0.045)	F		0000	
□N4K00E (4.040)	1.5 (0.059)	Н	1 —	2000	
□MK325(1210)	1.9 (0.075)	N	1		
	2.0max(0.079)	Y	_	2000	
	2.5 (0.098)	М	_	500(T), 1000(P)	
☐MK432(1812)	2.5 (0.098)	М	_	500	

# ②テーピング材質 Taping material 紙テープ

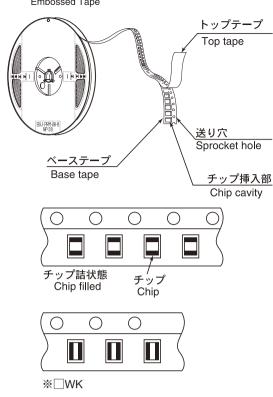
 $\bigcirc$ 

 $\#\square WK$ 

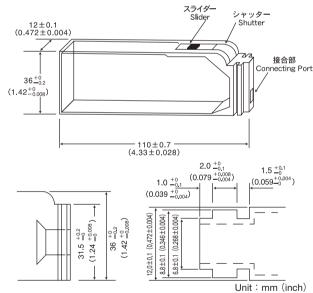
※プレスポケットタイプは、 ボトムテープ無し。





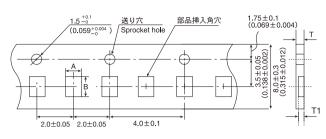


#### ③バルクカセット Bulk Cassette



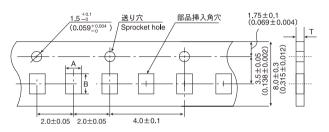
105, 107, 212形状で個別対応致しますのでお問い合せ下さい。 Please contact any of our offices for accepting your requirement according to dimensions 0402, 0603, 0805.(inch)

③テーピング寸法 Taping dimensions 紙テープ Paper Tape(8mm幅)(0.315inches wide)



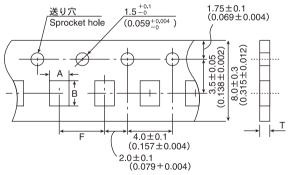
Type (EIA)		挿入部 Cavity	挿入ピッチ Insertion Pitch		テープ厚み Tape Thickness		
(ETA)	A B		F	Т	T1		
☐MK042(01005)	0.25	0.45	2.0±0.05	0.36max.	0.27max.		
	(0.010)	(0.018)	(0.079±0.002)	(0.014)	(0.011)		
☐MK063(0201)	0.37	0.67	2.0±0.05	0.45max.	0.42max.		
	(0.016)	(0.027)	(0.079±0.002)	(0.018)	(0.017)		
□WK105(0204)	0.65	1.15	2.0±0.05	0.45max	0.42max		
	(0.026)	(0.045)	(0.079±0.002)	(0.018max)	(0.017max)		

Unit: mm (inch)



T	チッフ	<sup>°</sup> 挿入部	挿入ピッチ	テープ厚み	
Type	Chip (	Cavity	Insertion Pitch	Tape Thickness	
(EIA)	Α	В	F	Т	
	0.72	1.02	2.0±0.05	0.45max.(0.018max)	
□2K096 (0302)	(0.028)	(0.040)	(0.079±0.002)	0.6max.(0.024max)	
☐MK105(0402)	0.65	1.15	2.0±0.05	0.8max.	
□VK105(0402)	(0.026)	(0.045)	(0.079±0.002)	(0.031max.)	

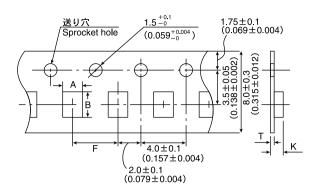
Unit: mm (inch)



-	チッフ	"挿入部	挿入ピッチ	テープ厚み	
Type (EIA)	Chip (	Cavity	Insertion Pitch	Tape Thickness	
(EIA)	Α	В	F	Т	
☐MK107(0603)	1.0	1.8	4.0±0.1	1.1max.	
□WK107(0306)	(0.039)	(0.071)	(0.157±0.004)	(0.043max.)	
□0K140(0E04)	1.15	1.55	4.0±0.1	1.0max.	
□2K110 (0504)	(0.045)	(0.061)	(0.157±0.004)	(0.039max.)	
□MK212(0805) □WK212(0508)	1.65	2.4			
□4K212(0805)	(0.065)	(0.094)	4.0±0.1	1.1max.	
□2K212(0805)			(0.157±0.004)	(0.043max.)	
□MK316(1206)	2.0	3.6			
□NIN3 16 (1206)	(0.079)	(0.142)			

Unit: mm (inch)

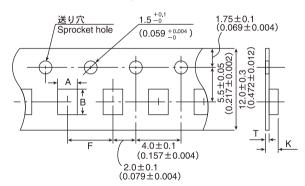
エンボステープ Embossed tape (8mm幅) (0.315inches wide)



T	チップ	°挿入部	挿入ピッチ	テープ厚み	
Type	Chip	cavity	Insertion Pitch	Tape Thickness	
(EIA)	Α	В	F	K	Т
	1.0	1.8		1.3max.	0.25±0.1
□WK107 (0306)	(0.039)	(0.071)		(0.051max.)	(0.01±0.004)
	1.65	2.4			
□MK212 (0805)	(0.065)	(0.094)	4.0±0.1		
	2.0	3.6	(0.157±0.004)	3.4max.	0.6max.
□MK316 (1206)	(0.079)	(0.142)		(0.134max.)	(0.024max.)
	2.8	3.6	1		
☐MK325 (1210)	(0.110)	(0.142)			

Unit: mm (inch)

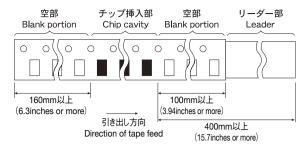
エンボステープ Embossed tape (12mm幅) (0.472inches wide)



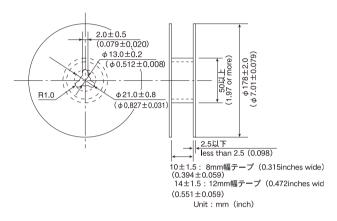
Type		°挿入部	挿入ピッチ			
	Chip (	cavity	Insertion Pitch	Tape Th	ickness	
(EIA)	А	A B F		K	Т	
☐MK432 (1812)	3.7 (0.146)	4.9 (0.193)	8.0±0.1 (0.315±0.004)	4.0max. (0.157max.)	0.6max. (0.024max.)	
Unit: mm (inch)						

### 梱包 PACKAGING

# ④リーダー部/空部 Leader and Blank portion

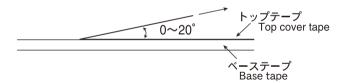


#### ⑤リール寸法 Reel size



#### ⑥トップテープ強度 Top Tape Strength

トップテープのはがし力は下図矢印方向にて $0.1\sim0.7$ Nとなります。 The top tape requires a peel-off force of  $0.1\sim0.7$ N in the direction of the arrow as illustrated below.



#### Multilayer Ceramic Capacitor Chips

			Specific	ed Value		
It	em	Temperature Comp	pensating (Class 1)	High Permiti	vity (Class 2)	Test Methods and Remarks
		Standard	High Frequency Type	Standard Note1	High Value	
1.Operating Range	Temperature	-55 to +125℃		BJ: -55 to +125°C F: -25 to +85°C	-25 to +85°C	High Capacitance Type BJ (X7R): -55~+125°C, BJ (X5R): -55~+86°C E (Y5U): -30~+85°C, F (Y5V): -30~+86°C
2.Storage 1 Range	Temperature	−55 to +125°C		BJ: −55 to +125°C F: −25 to +85°C	−25 to +85°C	$\label{eq:bight}  \begin{tabular}{lllllllllllllllllllllllllllllllllll$
3.Rated Voltaç	ge	50VDC,25VDC, 16VDC	16VDC 50VDC	50VDC,25VDC	50VDC,35VDC,25VDC 16VDC,10VDC,6.3VDC 4DVC, 2.5VDC	
4. Withstanding Voltage Between terminals		No breakdown or damage		No breakdown or dama	ge	Applied voltage: Rated voltage ×3 (Class 1) Rated voltage ×2.5 (Class 2) Duration: 1 to 5 sec. Charge/discharge current: 50mA max. (Class 1,2)
5.Insulation Re	esistance	10000 MΩ min.		500 M $\Omega$ $\mu$ F. or 10000 smaller.	$M\Omega$ ., whichever is the	Applied voltage: Rated voltage  Duration: 60±5 sec.  Charge/discharge current: 50mA max.
6.Capacitance	e (Tolerance)	0.5 to 5 pF: ±0.25 pF 1 to 10 pF: ±0.5 pF 5 to 10 pF: ±1 pF 11 pF or over: ±5% ±10% 105TYPERA, \$A, TA, UA only 0.5~2pF: ±0.1pF 2.2~20pF: ±5%	0.5 to 2 pF: ±0.1 pF 2.2 to 5.1 pF: ±5%	BJ: ±10%, ±20% F: +80% -20	BJ: ±10%, ±20% F: -20%/+80%	Measuring frequency: Class1: 1MHz±10% (C≦1000pF) 1 k Hz±10% (C≤1000pF) Class2: 1 k Hz±10% (C≤100 μF) 120Hz±10Hz (C>10 μF) 120Hz±10Hz (C>10 μF) Measuring voltage: Note 4 Class1: 0.5~5Vrms (C≤1000pF) 1±0.2Vrms (C>1000pF) Class2: 1±0.2Vrms (C≤10 μF) 0.5±0.1Vrms (C>10 μF) Bias application: None
7.Q or Tangent $( an \ \delta \ )$	of Loss Angle	Under 30 pF : Q≥400 + 20C 30 pF or over : Q≥1000 C= Nominal capacitance	Refer to detailed specification	BJ: 2.5% max. (50V, 25V) F: 5.0% max. (50V, 25V) Note 4	BJ: 2.5% max. F: 7% max. Note 4	$\begin{array}{lll} & \text{Multilayer:} \\ & \text{Measuring frequency:} \\ & \text{Class1: } 1 \text{MHz} \pm 10\%  (\text{C} \leq 1000 \text{pF}) \\ & 1 \text{ k Hz} \pm 10\%  (\text{C} > 1000 \text{pF}) \\ & 1 \text{ k Hz} \pm 10\%  (\text{C} \leq 10  \mu \text{F}) \\ & 120 \text{Hz} \pm 10 \text{Hz}  (\text{C} \leq 10  \mu \text{F}) \\ & 120 \text{Hz} \pm 10 \text{Hz}  (\text{C} \geq 10  \mu \text{F}) \\ & 120 \text{Hz} \pm 10 \text{Hz}  (\text{C} \geq 10  \mu \text{F}) \\ & 120 \text{ Lyrms}  (\text{C} \leq 1000 \text{pF}) \\ & 1 \pm 0.2 \text{Vrms}  (\text{C} \geq 1000 \text{pF}) \\ & \text{Class2: } 1 \pm 0.2 \text{Vrms}  (\text{C} \geq 10  \mu \text{F}) \\ & \text{Class2: } 1 \pm 0.2 \text{Vrms}  (\text{C} \geq 10  \mu \text{F}) \\ & \text{D.5} \pm 0.1 \text{Vrms}  (\text{C} \geq 10  \mu \text{F}) \\ & \text{Bias application: None} \\ & \text{High} - \text{Frequency} - \text{Multilayer:} \\ & \text{Measuring frequency: } 1 \text{GHz} \\ & \text{Measuring equipment: HP4291A} \\ & \text{Measuring ig: HP16192A} \\ \end{array}$
8.Temperature Characteristic of Capacitance	(Without voltage ap- plication)	CK: 0±250 CJ: 0±120 CH: 0±60 CG: 0±30 RH: -220±60 SK: -330±250 SJ: -330±120 SH: -330±60 TK: -470±250 TJ: -470±120 UK: -750±250 UJ: -750±120 SL: +350 to -1000 (ppm/C)	CH: 0±60 RH: −220±60 (ppm/C)	BJ: ±10% (-25~85°C) F: +30% (-25~85°C) BJ (X7R): ±15% F (Y5V): +22%	BJ: ±10% (-25~+85°C) F: +30%/-80% (-25~+85°C) BJ (X7R, X5R): ±15% F (Y5V): +22%/-82%	According to JIS C 5102 clause 7.12. Temperature compensating: Measurement of capacitance at 20°C and 85°C shall be made to calculate temperature characteristic by the following equation. $\frac{(C_{85}-C_{20})}{C_{20}\times\triangle T}\times 10^{6}  (\text{ppm/°C})$ High permitivity: Change of maximum capacitance deviation in step 1 to 5 Temperature at step 1: $+20^{\circ}\text{C}$ Temperature at step 2: minimum operating temperature Temperature at step 3: $+20^{\circ}\text{C}$ (Reference temperature) Temperature at step 4: maximum operating temperature Temperature at step 5: $+20^{\circ}\text{C}$ Reference temperature for X7R, X5R, Y5U and Y5V shall be $+25^{\circ}\text{C}$
9.Resistance t Substrate	to Flexure of	Appearance: No abnormality Capacitance change: Within ±5% or ±0.5 pF, whichever is larger.	Appearance: No abnormality Capacitance change: Within±0.5 pF	Appearance: No abnormality Capacitance change: BJ: Within ±12.5% F: Within ±30%		Warp: 1mm Testing board: glass epoxy—resin substrate Thickness: 1.6mm (063 TYPE: 0.8mm) The measurement shall be made with board in the bent position.  Board  R-230  Warp  Warp  (Unit: mm)

# Multilayer Ceramic Capacitor Chips

		Specifie	ed Value		
Item	Temperature Comp	pensating (Class 1)	High Permitti	vity (Class 2)	Test Methods and Remarks
	Standard	High Frequency Type	Standard Note1	High Value	
10.Body Strength	_	No mechanical damage.	_	_	High Frequency Multilayer:  Applied force: 5N  Duration: 10 sec.  Press  Chip  (LW Reverse)
1.Adhesion of Electrode	No separation or indicat	l and the separation of elect	L rode.		Applied force: 5N (01005, 0201, 0302 TYPE 2N)  Duration: 30±5 sec. Hooked jig  Hooked jig  Chip  Cross-section
2.Solderability	At least 95% of termina	l electrode is covered by	new solder.		Solder temperature: 230±5°C  Duration: 4±1 sec.
13.Resistance to soldering	Appearance: No abnormality Capacitance change: Within ±2.5% or ±0.25pF, whichever is larger. Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±2.5% Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Capacitance change: Within $\pm 7.5\%$ (BJ) Within $\pm 20\%$ (F) tan $\delta$ : Initial value Note 4 Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality		Preconditioning: Thermal treatment (at 150°C for 1 hr)  (Applicable to Class 2.)  Solder temperature: 270±5°C  Duration: 3±0.5 sec.  Preheating conditions: 80 to 100°C, 2 to 5 min. or 5 to 10 mir  150 to 200°C, 2 to 5 min. or 5 to 10 mir  Recovery: Recovery for the following period under the standard condition after the test.  6~24 hrs (Class 1)  24±2 hrs (Class 2)
14.Thermal shock	Appearance: No abnormality Capacitance change: Within ± 2.5% or ±0.25pF, whichever is larger. Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Appearance: No abnormality Capacitance change: Within ±0.25pF Q: Initial value Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality	Capacitance change: Within $\pm 7.5\%$ (BJ) Within $\pm 20\%$ (F) tan $\delta$ : Initial value Note 4 Insulation resistance: Initial value Withstanding voltage (between terminals): No abnormality		Preconditioning: Thermal treatment (at $150^{\circ}\text{C}$ for 1 hr) (Applicable to Class 2.)  Conditions for 1 cycle: Step 1: Minimum operating temperature $^{+0}_{-3}$ $^{\circ}\text{C}$ $30\pm3$ min Step 2: Room temperature 2 to 3 min Step 3: Maximum operating temperature $^{-0}_{+3}$ $^{\circ}\text{C}$ $30\pm3$ min Step 4: Room temperature 2 to 3 min Number of cycles: 5 times Recovery after the test: $6\sim24$ hrs (Class 1) $24\pm2$ hrs (Class 2)
15.Damp Heat (steady state)	Appearance: No abnormality Capacitance change: Within $\pm 5\%$ or $\pm 0.5 p F$ , whichever is larger. Q: $C \ge 30 \ p F : Q \ge 350 \ 10 \le C < 30 \ p F : Q \ge 275 + 2.5 C \ C < 10 \ p F : Q \ge 200 \ + 10 C \ C: Nominal capacitance Insulation resistance: 1000 \ M\Omega min.$	Appearance: No abnormality Capacitance change: Within ±0.5pF, Insulation resistance: 1000 MΩ min.	Appearance: No abnormality Capacitance change: BJ: Within $\pm 12.5\%$ F: Within $\pm 30\%$ tan $\delta$ : BJ: 5.0% max. F: 7.5% max. Note 4 Insulation resistance: $50~\text{M}\Omega~\mu\text{F}$ or $1000~\text{M}\Omega$ whichever is smaller. Note 5	Appearance: No abnormality Capacitance change: BJ:Within $\pm 12.5\%$ Note 4 tan $\delta$ : BJ: 5.0% max. Note 4. F: 11.0% max. Insulation resistance: $50~\mathrm{M}\Omega~\mu\mathrm{F}$ or $1000~\mathrm{M}\Omega$ whichever is smaller. Note 5	Multilayer: Preconditioning: Thermal treatment (at 150°C for 1 hr)  (Applicable to Class 2.)  Temperature: 40±2°C  Humidity: 90 to 95% RH  Duration: 500 <sup>+24</sup> / <sub>0</sub> hrs  Recovery: Recovery for the following period under the standard condition after the removal from test chamber: 6~24 hrs (Class 1) 24±2 hrs (Class 2)  High—Frequency Multilayer: Temperature: 60±2°C  Humidity: 90 to 95% RH  Duration: 500 <sup>+24</sup> / <sub>0</sub> hrs  Recovery: Recovery for the following period under the standard condition after the removal from test chamber: 6~24 hrs (Class 1)

#### Multilayer Ceramic Capacitor Chips

		Specifie			
Item	Temperature Compensating (Class 1)		High Permittiv	vity (Class 2)	Test Methods and Remarks
	Standard	High Frequency Type	Standard Note1	High Value	
16.Loading under Damp Heat	Appearance: No abnormality Capacitance change: Within ±7.5% or ± 0.75pF, whichever is larger. Q: C≧30 pF: Q≧200 C<30 pF: Q≧100 + 10C/3 C: Nominal capacitance Insulation resistance: 500 MΩ min.	Appearance: No abnormality Capacitance change: C≤2 pF: Within ±0.4 pF C>2 pF: Within ±0.75 pF C: Nominal capacitance Insulation resistance: 500 MΩ min.	Appearance: No abnormality Capacitance change: BJ: Within $\pm 12.5\%$ F: Within $\pm 30\%$ Note 4 tan $\delta$ : BJ: 5.0% max. F: 7.5% max. Note 4 Insulation resistance: $25~{\rm M}\Omega\mu{\rm F}$ or $500~{\rm M}\Omega$ , whichever is the smaller. Note 5	Appearance: No abnormality Capacitance change: BJ: Within $\pm 12.5\%$ F: Within $\pm 30\%$ Note 4 tan $\delta$ : BJ: 5.0% max. F: 11% max. Note 4 Insulation resistance: $25~\mathrm{M}\Omega\mu\mathrm{F}$ or $500~\mathrm{M}\Omega$ , whichever is the smaller. Note 5	According to JIS C 5102 Clause 9. 9.  Multilayer: Preconditioning: Voltage treatment (Class 2) Temperature: 40±2°C Humidity: 90 to 95% RH Duration: 500 +24 hrs Applied voltage: Rated voltage Charge and discharge current: 50mA max. (Class 1,2) Recovery: Recovery for the following period under the standarcondition after the removal from test chamber. 6 +24 hrs (Class 1) 24±2 hrs (Class 2) High—Frequency Multilayer: Temperature: 60±2°C Humidity: 90 to 95% RH Duration: 500 +24 hrs Applied voltage: Rated voltage Charge and discharge current: 50mA max. Recovery: 6 +24 hrs of recovery under the standarcondition after the removal from test chamber.
17.Loading at High Temperature	Appearance: No abnormality Capacitance change: Within ±3% or ±0.3pF, whichever is larger. Q: C≧30 pF: Q≧350 10≦C<30 pF: Q≧275 + 2.5C C<10 pF: Q≧200 + 10C C: Nominal capacitance Insulation resistance: 1000 MΩ min.	Appearance: No abnormality Capacitance change: Within $\pm 3\%$ or $\pm$ 0.3pF, whichever is larger. Insulation resistance: 1000 M $\Omega$ min.	Appearance: No abnormality Capacitance change: BJ: Within $\pm$ 12.5% F: Within $\pm$ 30% Note 4 tan $\delta$ : BJ: 4.0% max. F: 7.5% max. Note 4 Insulation resistance: $50~\mathrm{M}\Omega~\mu$ F or $1000~\mathrm{M}\Omega$ , whichever is smaller. Note 5	Appearance: No abnormality Capacitance change: BJ: Within $\pm 12.5\%$ Within $\pm 20\% * \%$ Within $\pm 25\% * \%$ F: Within $\pm 30\%$ Note 4 $\tan \delta$ : BJ: $5.0\%$ max. F: $11\%$ max. Note 4 Insulation resistance: $50~\mathrm{M}\Omega~\mu\mathrm{F}$ or $1000~\mathrm{M}\Omega$ , whichever is smaller. Note 5	According to JIS C 5102 clause 9.10.  Multilayer: Preconditioning: Voltage treatment (Class 2) Temperature:125±3°C (Class 1, Class 2: B, BJ (X7R) 85±2°C (Class 2: BJ,F) Duration: 1000 <sup>+48</sup> <sub>-</sub> hrs Applied voltage: Rated voltage×2 Note 6 Recovery: Recovery for the following period under the standard condition after the removal from test chambe 6~24 hrs (Class 1) 24±2 hrs (Class 2) High—Frequency Multilayer: Temperature: 125±3°C (Class 1) Duration: 1000 <sup>+48</sup> <sub>-</sub> hrs Applied voltage: Rated voltage×2 Recovery: 6~24 hrs of recovery under the standal condition after the removal from test chamber

Note 1 :For 105 type, specified in "High value".

Note 2 :Thermal treatment (Multilayer): 1 hr of thermal treatment at 150 +0 /- 10 °C followed by 24±2 hrs of recovery under the standard condition shall be performed before the measurement.

Note 3 :Voltage treatment (Multilayer): 1 hr of voltage treatment and voltage for testing followed by 24±2 hrs of recovery under the standard condition shall be performed before the measurement.

Note 4, 5 :The figure indicates typical inspection. Please refer to individual specifications.

Note 6 :Some of the parts are applicable in rated voltage × 1.5. Please refer to individual specifications.

Note on standard condition: "standard condition" referred to herein is defined as follows: 5 to 35°C of temperature, 45 to 85% relative humidity, and 86 to 106kPa of air pressure.

When there are questions concerning measurement results: In order to provide correlation data, the test shall be conducted under condition of 20±2°C of temperature, 60 to 70% relative humidity, and 86 to 106kPa of air pressure. Unless otherwise specified, all the tests are conducted under the "standard condition."

Stages	Precautions	Technical considerations
1.Circuit Design	Verification of operating environment, electrical rating and performance  1. A malfunction in medical equipment, spacecraft, nuclear reactors, etc. may cause serious harm to human life or have severe social ramifications. As such, any capacitors to be used in such equipment may require higher safety and/or reliability considerations and should be clearly differentiated from components used in general purpose applications.  Operating Voltage (Verification of Rated voltage)  1. The operating voltage for capacitors must always be lower than their rated values.  If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages should be lower than the rated value of the capacitor chosen. For a circuit where both an AC and a pulse voltage may be present, the sum of their peak voltages should also be lower than the capacitor's rated voltage.  2. Even if the applied voltage is lower than the rated value, the reliability of capacitors might be reduced if either a high frequency AC voltage or a pulse voltage having rapid rise time is present in the circuit.	
2.PCB Design	Pattern configurations (Design of Land-patterns)  1. When capacitors are mounted on a PCB, the amount of solder used (size of fillet) can directly affect capacitor performance. Therefore, the following items must be carefully considered in the design of solder land patterns:  (1) The amount of solder applied can affect the ability of chips to withstand mechanical stresses which may lead to breaking or cracking. Therefore, when designing land-patterns it is necessary to consider the appropriate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets.  (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by solder-resist.	1.The following diagrams and tables show some examples of recommended patterns to prevent excessive solder amourts. (larger fillets which extend above the component end terminations)  Examples of improper pattern designs are also shown.  (1) Recommended land dimensions for a typical chip capacitor land patterns for PCBs  Land pattern  Chip capacitor  Solder-resist  Chip capacitor  W  Recommended land dimensions for wave-soldering (unit: mm)  Type  107  212  316  325  L  1.6  2.5  A  0.8~1.0  1.0~1.4  1.8~2.5  1.8~2.5  B  0.5~0.8  0.8~1.5  0.8~1.7  0.8~1.7  C  0.6~0.8  0.9~1.2  1.2~1.6  1.8~2.5
		Type

Size W

а

С

Type 212 (2 circuits) 110 (2 circuits) 096 (2 circuits)

1.37

1.0

0.5~0.6 0.55~0.65 0.15~0.25 0.5~0.6 0.3~0.4 0.15~0.25

0.64

0.35~0.45 0.25~0.35

0.9

0.6

2.0

1.25

0.5~0.6

a

Stages	Precautions					Те	chnical con	siderations
		L۱	WDC I	Rec	ommended	land dimer	sions for re	eflow-soldering
			<u>c</u> ↑	Ch	ip capacito	and patter	n Solder-re	esist
			Туре	е	105	107	212	
			Size	L	0.52	0.8	1.25	
			S	W	1.0	1.6	2.0	
			Α		0.18~0.22	0.25~0.3	0.5~0.7	
			В		0.2~0.25	0.3~0.4	0.4~0.5	
			С		0.9~1.1	1.5~1.7	1.9~2.1	
							(unit: mm)	

2.PCB Design

(2) Examples of good and bad solder application

Items	Not recommended	Recommended
Mixed mounting of SMD and leaded compo- nents	Lead wire of component	Solder-resist
Component placement close to the chassis	Chassis Solder(for grounding)	Solder-resist
Hand-soldering of leaded components near mounted components	Lead wire of component- Soldering iron	Solder-resist -
Horizontal component placement		Solder-resist

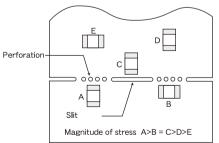
# Pattern configurations

(Capacitor layout on panelized [breakaway] PC boards)

1. After capacitors have been mounted on the boards, chips can be subjected to mechanical stresses in subsequent manufacturing processes (PCB cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering the reflow soldered boards etc.) For this reason, planning pattern configurations and the position of SMD capacitors should be carefully performed to minimize stress. 1-1. The following are examples of good and bad capacitor layout; SMD capacitors should be located to minimize any possible mechanical stresses from board warp or deflection.

	Not recommended	Recommended
Deflection of the board		Position the component at a right angle to the infection of the mechanical stresses that are anticipated.

1-2. To layout the capacitors for the breakaway PC board, it should be noted that the amount of mechanical stresses given will vary depending on capacitor layout. The example below shows recommendations for better design.



1-3. When breaking PC boards along their perforations, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful to most stressful: push-back, slit, V-grooving, and perforation. Thus, any ideal SMD capacitor layout must also consider the PCB splitting procedure.

	Viultilayer Ceramic Capacitors		<b>+</b>	
Stages	Precautions		Technical considera	ations
Adjustment of mounting machine  1. Excessive impact load should not be imposed on the capacitors when mounting onto the PC boards.  2. The maintenance and inspection of the mounters should be conducted periodically.		capacitors, cau before lowering (1) The lower limi PC board after (2) The pick-up p (3) To reduce the nozzle, support	ising damage. To avoid this, the form the pick-up nozzle: it of the pick-up nozzle should be correcting for deflection of the borressure should be adjusted between amount of deflection of the boars.	en 1 and 3 N static loads. and caused by impact of the pick-up be used under the PC board. The fol-
			Not recommended	Recommended
		Single-sided mounting	Cracks	Supporting pin-L
		Double-sided mounting	Solder peeling - Cracks -	Supporting pin-
		cracking of the this, the monito	capacitors because of mechanica	e nozzle height can cause chipping or al impact on the capacitors. To avoid ment pin in the stopped position, and in should be conducted periodically.
	Selection of Adhesives  1. Mounting capacitors with adhesives in preliminary assembly, before the soldering stage, may lead to degraded capacitor characteristics unless the following factors are appropriately checked; the size of land patterns, type of adhesive, amount applied, hardening temperature and hardening period. Therefore, it is imperative to consult the manufacturer of the adhesives on proper usage and amounts of adhesive to use.	the shrinkage p stresses on the adhesive applie lowing precauti  (1) Required adhe a. The adhesive s ing & solder pre b. The adhesive s c. The adhesive s e. The adhesive s f. The adhesive s h. The adhesive s h. The adhesive s f. The adhesive s c. The adhesive s f. The adhesive s	percentage of the adhesive and expansitors and lead to cracking to the board may adversely affectors should be noted in the applications should be strong enough to hold process. Should have sufficient strength at high the desired process and the strong enough to hold process. Should have good coating and thick should have good coating and thick should have excellent insulation chanced the strong enough to hold process. Should have excellent insulation chanced amount of adhesives is as for the strong enough to the strong enough e	parts on the board during the mountaigh temperatures. kness consistency. ad shelf life. haracteristics. mission of toxic gasses. bllows; s as examples min 0 µm

Stages	Precautions	Technical considerations
4. Soldering	Selection of Flux  1. Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use;  (1) Flux used should be with less than or equal to 0.1 wt% (equivelent to chroline) of halogenated content. Flux having a strong acidity content should not be applied.  (2) When soldering capacitors on the board, the amount of flux applied should be controlled at the optimum level.  (3) When using water-soluble flux, special care should be taken to properly clean the boards.	<ul> <li>1-1. When too much halogenated substance (Chlorine, etc.) content is used to activate the flux, or highly acidic flux is used, an excessive amount of residue after soldering may lead to corrosion of the terminal electrodes or degradation of insulation resistance on the surface of the capacitors.</li> <li>1-2. Flux is used to increase solderability in flow soldering, but if too much is applied, a large amount of flux gas may be emitted and may detrimentally affect solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system.</li> <li>1-3. Since the residue of water-soluble flux is easily dissolved by water content in the air, the residue on the surface of capacitors in high humidity conditions may cause a degradation of insulation resistance and therefore affect the reliability of the components. The cleaning methods and the capability of the machines used should also be considered carefully when selecting water-soluble flux.</li> </ul>
	Soldering Temperature, time, amount of solder, etc. are specified in accordance with the following recommended conditions.	1-1. Preheating when soldering Heating: Ceramic chip components should be preheated to within 100 to 130°C of the soldering.  Cooling: The temperature difference between the components and cleaning process should not be greater than 100°C.  Ceramic chip capacitors are susceptible to thermal shock when exposed to rapid or concentrated heating or rapid cooling. Therefore, the soldering process must be conducted with great care so as to prevent malfunction of the components due to excessive thermal shock.
	Sn-Zn solder paste can affect MLCC reliability performance. Please contact us prior to usage.	Recommended conditions for soldering  [Reflow soldering]  Temperature profile  Temperature (°C)  Solder I minute Over I minute O

Stages	Precautions	Technical considerations
4. Soldering		[Hand soldering]  Temperature profile  Temperature (*C) (Pb free soldering 400 400 300 400 400 400 400 400 400 400
5.Cleaning	Cleaning conditions  1. When cleaning the PC board after the capacitors are all mounted, select the appropriate cleaning solution according to the type of flux used and purpose of the cleaning (e.g. to remove soldering flux or other materials from the production process.)  2. Cleaning conditions should be determined after verifying, through a test run, that the cleaning process does not affect the capacitor's characteristics.	1. The use of inappropriate solutions can cause foreign substances such as flux residue to adhere to the capacitor or deteriorate the capacitor's outer coating, resulting in a degradation of the capacitor's electrical properties (especially insulation resistance).  2. Inappropriate cleaning conditions (insufficient or excessive cleaning) may detrimentally affect the performance of the capacitors.  (1) Excessive cleaning In the case of ultrasonic cleaning, too much power output can cause excessive vibration of the PC board which may lead to the cracking of the capacitor or the soldered portion, or decrease the terminal electrodes' strength. Thus the following conditions should be carefully checked;  Ultrasonic output  Below 20 W/ &  Ultrasonic frequency  Below 40 kHz  Ultrasonic washing period 5 min. or less
6.Post cleaning processes	1. With some type of resins a decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the capacitor's performance.  2. When a resin's hardening temperature is higher than the capacitor's operating temperature, the stresses generated by the excess heat may lead to capacitor damage or destruction. The use of such resins, molding materials etc. is not recommended.	Ontasonic washing period 3 min. or less
7.Handling	Breakaway PC boards (splitting along perforations)  1. When splitting the PC board after mounting capacitors and other components, care is required so as not to give any stresses of deflection or twisting to the board.  2. Board separation should not be done manually, but by using the appropriate devices.  Mechanical considerations  1. Be careful not to subject the capacitors to excessive mechanical shocks.  (1) If ceramic capacitors are dropped onto the floor or a hard surface, they should not be used.  (2) When handling the mounted boards, be careful that the mounted components do not come in contact with or bump against other boards or components.	

Stages	Precautions	Technical considerations
8.Storage conditions	Storage  1. To maintain the solderability of terminal electrodes and to keep the packaging material in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible.  Recommended conditions  Ambient temperature Below 30°C  Humidity Below 70% RH  The ambient temperature must be kept below 40°C. Even under ideal storage conditions capacitor electrode solderability decreases as time passes, so should be used within 6 months from the time of delivery.  Ceramic chip capacitors should be kept where no chlorine or sulfur exists in the air.  2. The capacitance value of high dielectric constant capacitors (type 2 &3) will gradually decrease with the passage of time, so this should be taken into consideration in the circuit design. If such a capacitance reduction occurs, a heat treatment of 150°C for 1hour will return the capacitance to its initial level.	1. If the parts are stored in a high temperature and humidity environment, problems such as reduced solderability caused by oxidation of terminal electrodes and deterioration of taping/packaging materials may take place. For this reason, components should be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the capacitors.

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